# Nano-carbon structures for electronic applications?

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## Outline



- Carbon Nano-structures: Applications in microelectronics
- Vertical Carbon devices
- Graphene Processing
- Other 2D Materials
- Carbon NEMS?
- Conclusions





- High Mobilities Ballistic conductance, massless Dirac fermions in graphene
- High Thermal Conductivity
- Room Temperature Quantum Effects
- Tuneable Band Gaps
- High surface area
- Chemically inert
- Mechanically stable



#### Potential Applications for Carbon Nanostructures in electronics









Structure metal contacts and Catalyst on wafer scale

Deposition by drop casting or CVD – random process!



Encapsulate CNT and Contact by electroless deposition

#### Apply Dielectric (Dip Coat Process!) and Top Gate (E-beam lithography)











⇒ Works at channels shorter 20 nm! Ballistic regime ⇒ Ultra high currents can be switched  $(I_{on} > 10 \mu A/tube)$ ⇒ On/off ratio > 10<sup>5</sup>



G.S. Duesberg, Ireland Summerschool, Leixlip, 30th August, 2011

Seidel, Duesberg et al.: Nano Letters, 2004







#### Throughput -

the number of wafers per hour optical lithography  $\rightarrow$  60 - 90 wafers/hour





#### Lateral dimmensions?



#### Accurate Positioning of CNTs ?



The vertical CNTFET could be the solution – but there is still a long way to go....



#### 10 **nm**

metal gate length can be adjusted to subnm accuracy by deposition

## The vertical transistor concept





## CVD of nano-carbon structures



 $CH_4 \rightarrow C_1 \rightarrow C_2 \rightarrow (C_4) \rightarrow C_6 \rightarrow C_n$  $\begin{array}{cccc} \downarrow & \downarrow & \downarrow & \downarrow & \\ C_{\infty} & C_{\infty} & & C_{\infty} & & C_{\infty} \end{array} \end{array} Pyrolysis of hydrocarbons \\ \end{array}$ 







CNTs by CVD

Pyrolytic Carbon (PyC)

Graphene by CVD

## Challenge: Structural homogenity of CVD CNTs









## Carbon Interconnects – PyC and CNTs





A. Graham, G. Schindler, G. S. Duesberg, T. Lutz, and W. Weber, Journal of Applied Physics, 107 114316.2010.



## Carbon devices: Memory and diode





Schottky diode: Duesberg, Kreupl, Graham et al.



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## CVD graphene & transfer





SEM

•Optical images of graphene films transferred to glass slides S. Kumar et al. Chem Comm 2010











## Conductive AFM in graphene films





Peter Nirmalraj, Tarek Lutz, Shishir Kumar, Georg Duesberg John Boland Nanoletters 2011

#### **Graphene on Copper**

## Low solubility of carbon

Less catalytic t Lattice match







![](_page_21_Picture_0.jpeg)

![](_page_21_Picture_2.jpeg)

Graphene transferred with polymers is cleaned with remote plasma at low temps

![](_page_21_Figure_4.jpeg)

![](_page_22_Picture_0.jpeg)

## Cleaning of graphene with plasmas

![](_page_22_Picture_2.jpeg)

![](_page_22_Figure_3.jpeg)

"Chemical" plasma by a remote source  $(R^{3}T \text{ TWR 2000-GEN, 400V})$  1000W . pressure of 1 torr flow rates of 100 sccm Oxygen and Hydrogen

![](_page_22_Picture_5.jpeg)

## Cleaning of graphene with plasmas only

![](_page_23_Figure_1.jpeg)

![](_page_23_Figure_2.jpeg)

![](_page_23_Figure_3.jpeg)

In-situ cleaning possible! Conductivity and mobilities increased ~ 200 cm<sup>2</sup>/Vs after plasma treatment This applies to all graphene type samples

Peltekis, Duesberg et al. Carbon, accepted

G.S. Duesberg, Ireland Summerschool, Leixlip, 30th August, 2011

![](_page_24_Picture_0.jpeg)

![](_page_24_Picture_2.jpeg)

Band gap ?

![](_page_24_Figure_4.jpeg)

![](_page_24_Picture_5.jpeg)

#### Avouris group IBM

![](_page_25_Picture_0.jpeg)

![](_page_25_Picture_2.jpeg)

#### **Double layers**

Zhang et al. 2009 Nature

![](_page_25_Picture_5.jpeg)

<u>Stress</u> Lu, Nano Research 2009

![](_page_25_Figure_7.jpeg)

![](_page_25_Figure_8.jpeg)

MPI – Metalforschung

#### **Functionalisation/ Doping**

![](_page_25_Figure_11.jpeg)

Gate Voltage (V)

#### Cut out/size effect

![](_page_25_Figure_14.jpeg)

![](_page_26_Picture_0.jpeg)

![](_page_26_Picture_2.jpeg)

Materials science: Nanotubes unzipped Mauricio Terrones Nature 458, 845-846(16 April 2009)

![](_page_26_Figure_4.jpeg)

#### Atomically defined structures!

![](_page_26_Figure_6.jpeg)

#### J. Cai, et al.Nature, 2010

#### Same or even more problems as with nanotubes

![](_page_27_Picture_0.jpeg)

![](_page_27_Picture_2.jpeg)

![](_page_27_Figure_3.jpeg)

![](_page_28_Picture_0.jpeg)

## Outline

![](_page_28_Picture_2.jpeg)

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![](_page_29_Picture_0.jpeg)

![](_page_29_Picture_2.jpeg)

![](_page_29_Figure_3.jpeg)

Layered compounds such as  $MoS_2,WS_2, MoSe_2,$  $MoTe_2, TaSe_2,$  $NbSe_2, NiTe_2,$  $BN, and Bi_2Te_3$  can be efficiently dispersed (also topological insulators?!)

Jonathan N. Coleman, Hye-Young Kim, Kangho Lee, Gyu Tae Kim, Georg S. Duesberg, Nicolosi, et al, "Two-Dimensional Nanosheets Produced by Liquid Exfoliation of Layered Materials", **Science**, 568-571, 2011

![](_page_30_Picture_0.jpeg)

![](_page_30_Picture_2.jpeg)

![](_page_30_Figure_3.jpeg)

![](_page_30_Picture_4.jpeg)

![](_page_31_Picture_0.jpeg)

![](_page_31_Figure_1.jpeg)

![](_page_31_Figure_2.jpeg)

Up to  $\mu = 195 \text{ cm}^2/\text{Vs}$  can be extracted based a model taken into thermal field emission (MSM). (similar to B. Radisavljevic , A. Kis, Nature Nano 2011)

Lee, Kim, Duesberg et al. Adv Mater., 2011

![](_page_31_Figure_6.jpeg)

![](_page_32_Picture_0.jpeg)

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![](_page_32_Picture_2.jpeg)

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![](_page_33_Picture_0.jpeg)

![](_page_33_Picture_2.jpeg)

•High on/off ration

- •Low power
- •High speed

•Carbon stable and light = high Q factors

![](_page_33_Figure_7.jpeg)

![](_page_33_Picture_8.jpeg)

![](_page_33_Picture_9.jpeg)

#### Bachthold et al. 2009

![](_page_34_Picture_0.jpeg)

![](_page_34_Picture_2.jpeg)

![](_page_34_Figure_3.jpeg)

#### Advantages

- very high on-off ratios
- can have very high operating frequencies
- can be used with loaded graphene for sensing applications
- -robust in extreme environments

#### Kumar et al. unpublished

#### Suspended graphene

![](_page_35_Picture_1.jpeg)

Surface tension breaks  $G \rightarrow$  use critical point dryer

![](_page_36_Picture_0.jpeg)

### Carbon NEMS devices

![](_page_36_Picture_2.jpeg)

![](_page_36_Figure_3.jpeg)

#### Overcome Subthreshold limit

#### Moving gate, Svenson et al. Nanoletters 2011

![](_page_36_Figure_6.jpeg)

![](_page_37_Picture_0.jpeg)

## Conclusions

![](_page_37_Picture_2.jpeg)

![](_page_37_Picture_3.jpeg)

Lateral carbon FETs may have application as power transistors or in flexible, transparent electronics, sensors etc. (More than Moore)

![](_page_37_Picture_5.jpeg)

Vertical FET face integration challenges (high k, contact engineering, Growth of CNTs) but have a lot of potential

Graphene can be synthesized and processed on the large scale but band gap engineering/passivation is crucial – potential for Spintronics and NEMS

New 2D Materials have a lot of potential for electronics and energy harvesting

![](_page_37_Picture_10.jpeg)

Carbon NEMS have superior properties

![](_page_38_Picture_0.jpeg)

## Acknowledgements

![](_page_38_Picture_2.jpeg)

![](_page_38_Picture_3.jpeg)

#### <u>Collaborators</u> Prof G.T Kim – Korea University Prof. Coleman – TCD Prof. Boland - TCD

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![](_page_38_Picture_10.jpeg)

![](_page_38_Picture_11.jpeg)